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Kind regards,

Team Nexperia



PBSS303NX

30 V, 5.1 A NPN low V_{CEsat} (BISS) transistor Rev. 02 — 20 November 2009

Product data sheet

Product profile 1.

1.1 General description

NPN low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a SOT89 (SC-62/TO-243) small and flat lead Surface-Mounted Device (SMD) plastic package.

PNP complement: PBSS303PX.

1.2 Features

- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

1.3 Applications

- DC-to-DC conversion
- MOSFET gate driving
- Motor control
- Charging circuits
- Power switches (e.g. motors, fans)

1.4 Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--------------------|---|--|-------|-----|------|------|
| V_{CEO} | collector-emitter voltage | open base | - | - | 30 | V |
| I _C | collector current | | - | - | 5.1 | Α |
| I _{CM} | peak collector current | $\begin{array}{l} \text{single pulse;} \\ t_p \leq 1 \text{ ms} \end{array}$ | - | - | 10.2 | Α |
| R _{CEsat} | collector-emitter saturation resistance | $I_C = 4 \text{ A};$ $I_B = 200 \text{ mA}$ | [1] - | 31 | 44 | mΩ |

[1] Pulse test: $t_p \le 300 \ \mu s; \ \delta \le 0.02.$



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30 V, 5.1 A NPN low V_{CEsat} (BISS) transistor

2. **Pinning information**

Table 2 **Pinning**

| Table 2. | - i iiiiiiig | | |
|----------|--------------|--------------------|----------------------|
| Pin | Description | Simplified outline | Symbol |
| 1 | emitter | | _ |
| 2 | collector | | 2 |
| 3 | base | 3 2 1 | 3 — 1 1 sym042 |

Ordering information 3.

Ordering information Table 3.

| Type number | Package | | | | | |
|-------------|---------|--|---------|--|--|--|
| | Name | Description | Version | | | |
| PBSS303NX | SC-62 | plastic surface-mounted package; collector pad for good heat transfer; 3 leads | SOT89 | | | |

Marking 4.

Table 4. **Marking codes**

| Type number | Marking code ^[1] |
|-------------|-----------------------------|
| PBSS303NX | *5D |

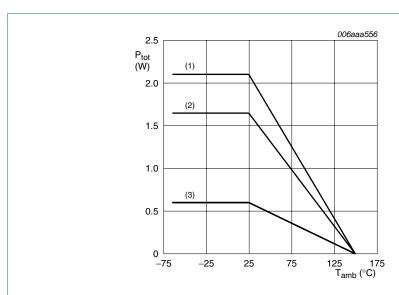
- [1] * = -: made in Hong Kong
 - * = p: made in Hong Kong
 - * = t: made in Malaysia
 - * = W: made in China

Limiting values 5.

Table 5. **Limiting values** In accordance with the Absolute Maximum Rating System (IEC 60134).

| | | , | , | | |
|------------------|---------------------------|--|--------------|------|------|
| Symbol | Parameter | Conditions | Min | Max | Unit |
| V_{CBO} | collector-base voltage | open emitter | - | 30 | V |
| V_{CEO} | collector-emitter voltage | open base | - | 30 | V |
| V_{EBO} | emitter-base voltage | open collector | - | 5 | V |
| I _C | collector current | | - | 5.1 | Α |
| I _{CM} | peak collector current | $\begin{array}{l} \text{single pulse;} \\ t_p \leq 1 \text{ ms} \end{array}$ | - | 10.2 | Α |
| P _{tot} | total power dissipation | $T_{amb} \le 25 ^{\circ}C$ | <u>[1]</u> _ | 0.6 | W |
| | | | [2] - | 1.65 | W |
| | | | [3] _ | 2.1 | W |
| Tj | junction temperature | | - | 150 | °C |
| T _{amb} | ambient temperature | | -65 | +150 | °C |
| T _{stg} | storage temperature | | -65 | +150 | °C |
| | | | | | |

- Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



- (1) Ceramic PCB, Al₂O₃, standard footprint
- (2) FR4 PCB, mounting pad for collector 6 cm²
- FR4 PCB, standard footprint

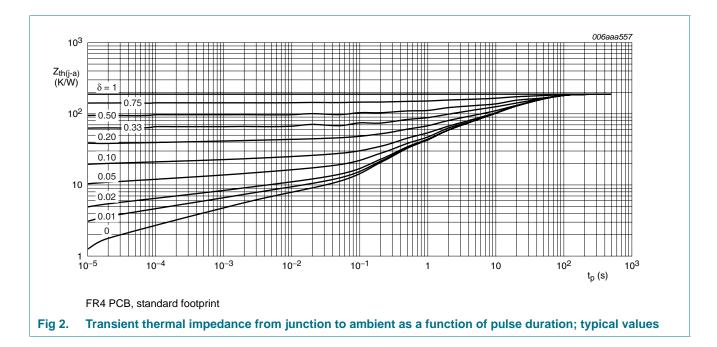
Power derating curves

6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------|--|-------------|--------------|-----|-----|------|
| $R_{th(j-a)}$ | thermal resistance from | in free air | <u>[1]</u> - | - | 208 | K/W |
| | junction to ambient | | [2] | - | 76 | K/W |
| | | | [3] | - | 60 | K/W |
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point | | - | - | 20 | K/W |

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- [3] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



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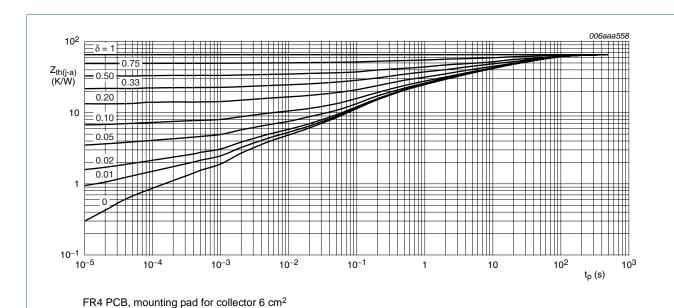


Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

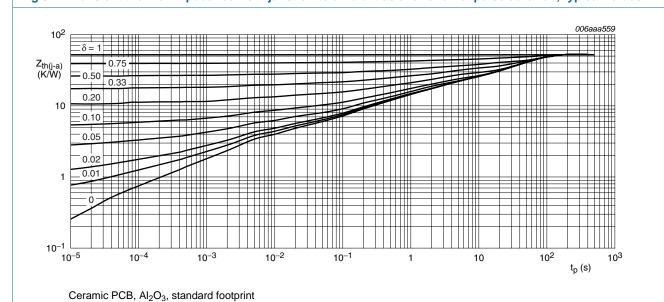


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

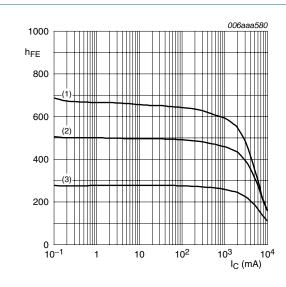
7. Characteristics

Table 7. Characteristics

 $T_{amb} = 25$ °C unless otherwise specified.

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|--------------------|------------------------------|--|------------|-----|------|------|-----------|
| I_{CBO} | collector-base cut-off | $V_{CB} = 30 \text{ V}; I_{E} = 0 \text{ A}$ | | - | - | 100 | nΑ |
| | current | $V_{CB} = 30 \text{ V; } I_E = 0 \text{ A;}$ $T_j = 150 ^{\circ}\text{C}$ | | - | - | 50 | μΑ |
| I _{EBO} | emitter-base cut-off current | $V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$ | | - | - | 100 | nA |
| h _{FE} | DC current gain | $V_{CE} = 2 \text{ V}; I_{C} = 0.5 \text{ A}$ | <u>[1]</u> | 300 | 480 | - | |
| | | V _{CE} = 2 V; I _C = 1 A | [1] | 300 | 460 | - | |
| | | $V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$ | [1] | 250 | 430 | - | |
| | | $V_{CE} = 2 \text{ V}; I_{C} = 4 \text{ A}$ | <u>[1]</u> | 200 | 360 | - | |
| | | $V_{CE} = 2 \text{ V}; I_{C} = 6 \text{ A}$ | <u>[1]</u> | 180 | 270 | - | |
| V_{CEsat} | collector-emitter | $I_C = 0.5 \text{ A}; I_B = 50 \text{ mA}$ | <u>[1]</u> | - | 20 | 30 | mV |
| | saturation voltage | $I_C = 1 A$; $I_B = 50 \text{ mA}$ | <u>[1]</u> | - | 40 | 60 | mV |
| | | $I_C = 1 A$; $I_B = 10 mA$ | [1] | - | 60 | 90 | mV |
| | | $I_C = 2 \text{ A}; I_B = 40 \text{ mA}$ | [1] | - | 80 | 110 | mV |
| | | I _C = 4 A; I _B = 200 mA | [1] | - | 125 | 175 | mV |
| | | I _C = 4 A; I _B = 400 mA | <u>[1]</u> | - | 120 | 170 | mV |
| | | I _C = 4 A; I _B = 40 mA | <u>[1]</u> | - | 160 | 250 | mV |
| | | I _C = 5.1 A; I _B = 255 mA | <u>[1]</u> | - | 150 | 220 | mV |
| R _{CEsat} | collector-emitter | $I_C = 4 \text{ A}; I_B = 200 \text{ mA}$ | [1] | - | 31 | 44 | $m\Omega$ |
| | saturation resistance | $I_C = 4 \text{ A}; I_B = 40 \text{ mA}$ | [1] | - | 40 | 63 | $m\Omega$ |
| V_{BEsat} | base-emitter | $I_C = 1 A$; $I_B = 100 \text{ mA}$ | [1] | - | 0.81 | 0.9 | V |
| | saturation voltage | $I_C = 4 \text{ A}; I_B = 400 \text{ mA}$ | [1] | - | 0.95 | 1.05 | V |
| V_{BEon} | base-emitter turn-on voltage | $V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$ | [1] | - | 0.75 | 0.85 | V |
| t _d | delay time | $V_{CC} = 12.5 \text{ V}; I_C = 3 \text{ A};$ | | - | 15 | - | ns |
| t _r | rise time | $I_{Bon} = 0.15 \text{ A};$ $I_{Boff} = -0.15 \text{ A}$ | | - | 50 | - | ns |
| t _{on} | turn-on time | 1Boff = -0.13 A | | - | 65 | - | ns |
| t _s | storage time | | | - | 305 | - | ns |
| t _f | fall time | | | - | 70 | - | ns |
| t _{off} | turn-off time | | | - | 375 | - | ns |
| f _T | transition frequency | $V_{CE} = 10 \text{ V}; I_{C} = 0.1 \text{ A};$ f = 100 MHz | | - | 130 | - | MHz |
| C _c | collector capacitance | $V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz | | - | 60 | 100 | pF |

^[1] Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$



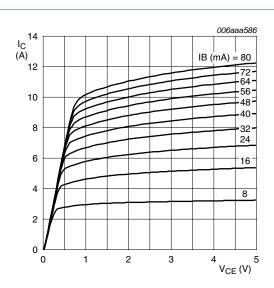
$$V_{CE} = 2 V$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

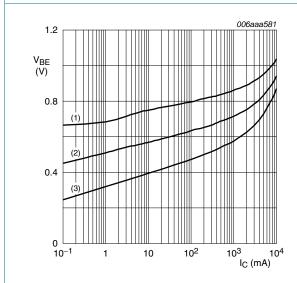
(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 5. DC current gain as a function of collector current; typical values



 $T_{amb} = 25 \, ^{\circ}C$

Fig 6. Collector current as a function of collector-emitter voltage; typical values

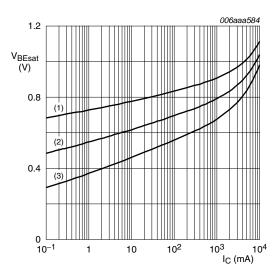


 $V_{CE} = 2 V$

(1)
$$T_{amb} = -55 \,^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

Base-emitter voltage as a function of collector Fig 7. current; typical values



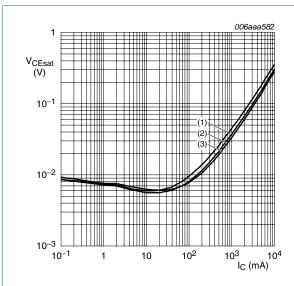
$$I_C/I_B = 20$$

(1)
$$T_{amb} = -55 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = 100 \, ^{\circ}C$$

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values



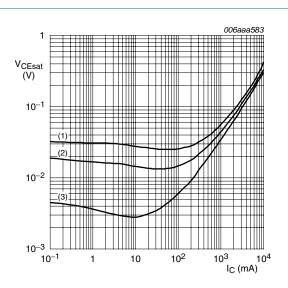
 $I_{\rm C}/I_{\rm B} = 20$

(1) $T_{amb} = 100 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

(3) $T_{amb} = -55 \, ^{\circ}C$

Collector-emitter saturation voltage as a Fig 9. function of collector current; typical values



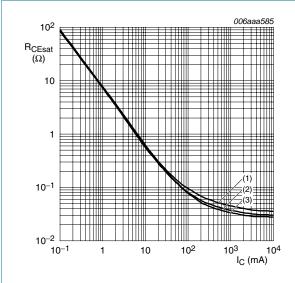
 $T_{amb} = 25 \, ^{\circ}C$

(1) $I_C/I_B = 100$

(2) $I_C/I_B = 50$

(3) $I_C/I_B = 10$

Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values



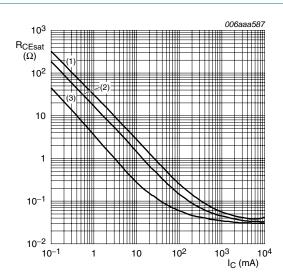
 $I_{\rm C}/I_{\rm B}=20$

(1) $T_{amb} = 100 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

(3) $T_{amb} = -55 \, ^{\circ}C$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values



T_{amb} = 25 °C

(1) $I_C/I_B = 100$

(2) $I_C/I_B = 50$

(3) $I_C/I_B = 10$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

Test information

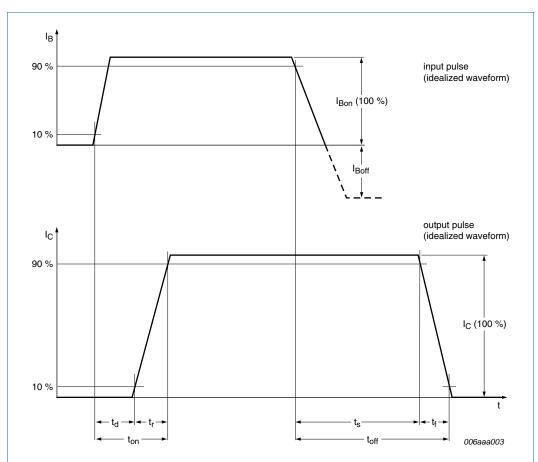
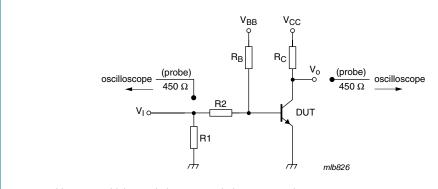


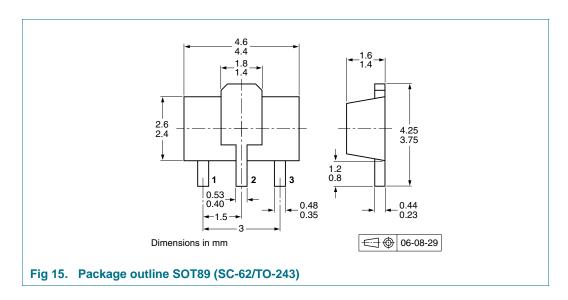
Fig 13. BISS transistor switching time definition



 V_{CC} = 12.5 V; I_{C} = 3 A; I_{Bon} = 0.15 A; I_{Boff} = -0.15 A

Fig 14. Test circuit for switching times

9. Package outline



10. Packing information

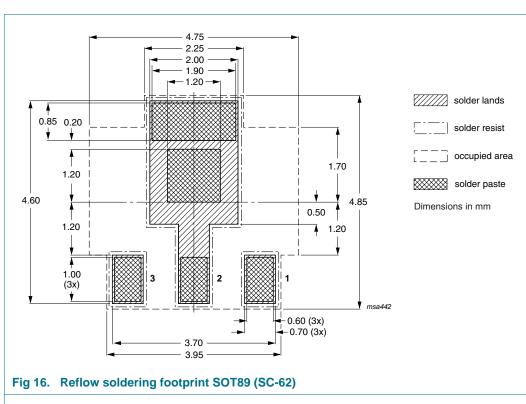
Table 8. Packing methods

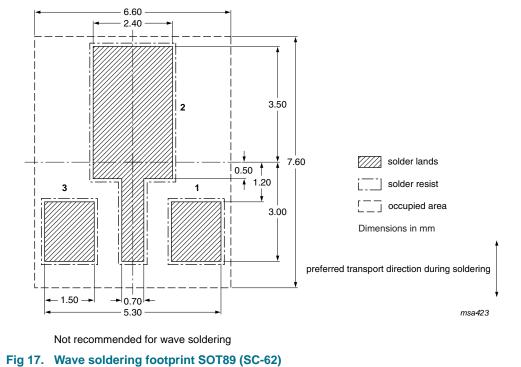
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

| Type number | Package | Description Packing | | g quantity | |
|-------------|---------|---------------------------------|------|------------|--|
| | | | 1000 | 4000 | |
| PBSS303NX | SOT89 | 8 mm pitch, 12 mm tape and reel | -115 | -135 | |

[1] For further information and the availability of packing methods, see Section 15.

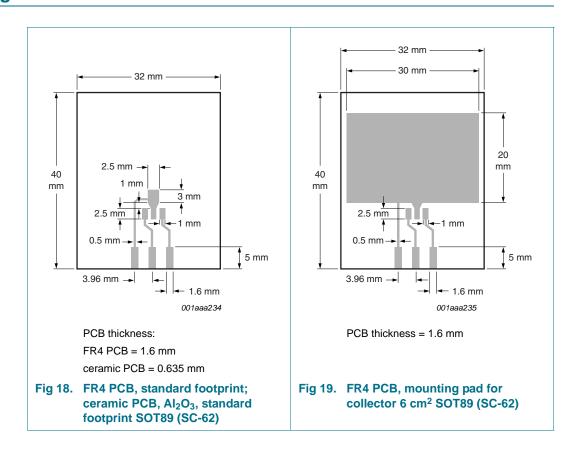
11. Soldering





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12. Mounting



13. Revision history

Table 9. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|----------------|-----------------------------------|---|-----------------------|-------------|
| PBSS303NX_2 | 20091120 | Product data sheet | - | PBSS303NX_1 |
| Modifications: | | eet was changed to reflect w legal definitions and discl | | |
| | Figure 15 "P. | ackage outline SOT89 (SC | -62/TO-243)": updated | |
| | Figure 16 "R | eflow soldering footprint SC | OT89 (SC-62)": update | d |
| | Figure 17 "W | lave soldering footprint SO | T89 (SC-62)": updated | |
| PBSS303NX_1 | 20060823 | Product data sheet | - | - |

14. Legal information

14.1 Data sheet status

| Document status[1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
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- [2] The term 'short data sheet' is explained in section "Definitions".
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PBS303NX_2

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